

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

High Frequency Automotive Grade

NP0 16 V TO 50 V

0.1 pF to 100 pF RoHS compliant & Halogen Free



YAGEO

Downloaded From Oneyac.com





Surface-Mount Ceramic Multilayer Capacitors

High Frequency Automotive grade

16 V to 50 V NP0

15

SCOPE

This specification describes Automotive grade NPO series chip capacitors with lead-free terminations and used for automotive equipments.

<u>APPLICATIONS</u>

All general purpose applications Entertainment applications Comfort / security applications Information applications

FEATURES

- AEC-Q200 qualified
- MSL class: MSL I
- AQ series soldering is compliant with J-STD-020D
- Halogen free epoxy
- RoHS compliant
- Reduce environmentally hazardous waste
- High component and equipment reliability
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AQ xxxx x x xxx x x xxx(2) (3) (4) (5) (6) (7)

(I) SIZE - INCH BASED (METRIC)

0603 (1608)

(2) TOLERANCE

0.1pF

 $B = \pm 0.1 pF$

0.2pF to 2.0pF

 $A = \pm 0.05 pF$

 $B = \pm 0.1 pF$

 $C = \pm 0.25 pF$

2.1 pF to 5.0 pF

 $A = \pm 0.05 pF$

 $B = \pm 0.1 pF$

 $C = \pm 0.25 \text{ pF}$

 $D = \pm 0.5 pF$

5.1 pF to 9.9 pF

 $B = \pm 0.1 pF$

 $C = \pm 0.25 pF$

 $D = \pm 0.5 pF$

10pF and over

 $F = \pm 1\%$

 $G = \pm 2\%$

 $| = \pm 5\%$

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

(4) TC MATERIAL

NPO

(5) RATED VOLTAGE

7 = 16 V

8 = 25 V

9 = 50 V

(6) PROCESS

N = NP0

(7) CAPACITANCE VALUE

2 significant digits+number of zeros

The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$

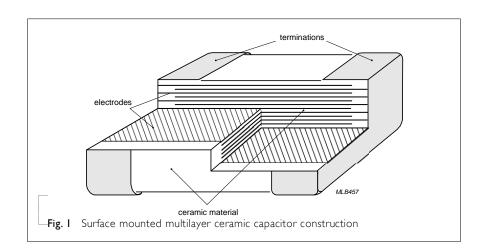
NP0

CONSTRUCTION

YAGEO

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are leadfree. A cross section of the structure is shown in Fig.I.

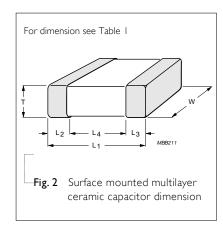


DIMENSION

Table I For outlines see fig. 2

TYPE	L _I (mm)	W (mm)	T (MM)	L ₂ , min.	/ L ₃ (mm) max.	L ₄ (mm) min.
0402	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15	0.35	0.40
0603	1.6 ±0.10	0.8 ±0.10	0.8 ±0.10	0.20	0.60	0.40

OUTLINES







Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

CAPACITANCE RANGE & THICKNESS FOR NPO

Table 2 Sizes 0402 to 0603

				es 0402 to 0603	Table 2 Siz
0603	0402	CAP.	0603	0402	CAP.
50 V	50 V		50 V	50V	
0.8±0.1	0.5±0.05	2.6 pF		0.5±0.05	0.1 pF
0.8±0.1	0.5±0.05	2.7 pF	0.8±0.1	0.5±0.05	0.2 pF
0.8±0.1	0.5±0.05	2.8 pF	0.8±0.1	0.5±0.05	0.3 pF
0.8±0.1	0.5±0.05	2.9 pF	0.8±0.1	0.5±0.05	0.4 pF
0.8±0.1	0.5±0.05	3.0 pF	0.8±0.1	0.5±0.05	0.5 pF
0.8±0.1	0.5±0.05	3.1 pF	0.8±0.1	0.5±0.05	0.6 pF
0.8±0.1	0.5±0.05	3.2 pF	0.8±0.1	0.5±0.05	0.7 pF
0.8±0.1	0.5±0.05	3.3 pF	0.8±0.1	0.5±0.05	0.8 pF
0.8±0.1	0.5±0.05	3.4 pF	0.8±0.1	0.5±0.05	0.9 pF
0.8±0.1	0.5±0.05	3.5 pF	0.8±0.1	0.5±0.05	1.0 pF
0.8±0.1	0.5±0.05	3.6 pF	0.8±0.1	0.5±0.05	1.1 pF
0.8±0.1	0.5±0.05	3.7 pF	0.8±0.1	0.5±0.05	1.2 pF
0.8±0.1	0.5±0.05	3.8 pF	0.8±0.1	0.5±0.05	1.3 pF
0.8±0.1	0.5±0.05	3.9 pF	0.8±0.1	0.5±0.05	1.4 pF
0.8±0.1	0.5±0.05	4.0 pF	0.8±0.1	0.5±0.05	1.5 pF
0.8±0.1	0.5±0.05	4.1 pF	0.8±0.1	0.5±0.05	1.6 pF
0.8±0.1	0.5±0.05	4.2 pF	0.8±0.1	0.5±0.05	1.7 pF
0.8±0.1	0.5±0.05	4.3 pF	0.8±0.1	0.5±0.05	1.8 pF
0.8±0.1	0.5±0.05	4.4 pF	0.8±0.1	0.5±0.05	1.9 pF
0.8±0.1	0.5±0.05	4.5 pF	0.8±0.1	0.5±0.05	2.0 pF
0.8±0.1	0.5±0.05	4.6 pF	0.8±0.1	0.5±0.05	2.1 pF
0.8±0.1	0.5±0.05	4.7 pF	0.8±0.1	0.5±0.05	2.2 pF
0.8±0.1	0.5±0.05	4.8 pF	0.8±0.1	0.5±0.05	2.3 pF
0.8±0.1	0.5±0.05	4.9 pF	0.8±0.1	0.5±0.05	2.4 pF
0.8±0.1	0.5±0.05	5.0 pF	0.8±0.1	0.5±0.05	2.5 pF

NOTE

- 1. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-I2 series is on request



CAPACITANCE RANGE & THICKNESS FOR NPO

Table 3 Sizes 0402 to 0603

YAGEO

CAP.	0402	0603	CAP.	0402	0603
C/ ti .	50V	50 V	C/ II .	50 V	50 V
5.1 pF	0.5±0.05	0.8±0.1	8.2 pF	0.5±0.05	0.8±0.1
5.2 pF	0.5±0.05	0.8±0.1	8.3 pF	0.5±0.05	0.8±0.1
5.3 pF	0.5±0.05	0.8±0.1	8.4 pF	0.5±0.05	0.8±0.1
5.4 pF	0.5±0.05	0.8±0.1	8.5 pF	0.5±0.05	0.8±0.1
5.5 pF	0.5±0.05	0.8±0.1	8.6 pF	0.5±0.05	0.8±0.1
5.6 pF	0.5±0.05	0.8±0.1	8.7 pF	0.5±0.05	0.8±0.1
5.7 pF	0.5±0.05	0.8±0.1	8.8 pF	0.5±0.05	0.8±0.1
5.8 pF	0.5±0.05	0.8±0.1	8.9 pF	0.5±0.05	0.8±0.1
5.9 pF	0.5±0.05	0.8±0.1	9.0 pF	0.5±0.05	0.8±0.1
6.0 pF	0.5±0.05	0.8±0.1	9.1 pF	0.5±0.05	0.8±0.1
6.1 pF	0.5±0.05	0.8±0.1	9.2 pF	0.5±0.05	0.8±0.1
6.2 pF	0.5±0.05	0.8±0.1	9.3 pF	0.5±0.05	0.8±0.1
6.3 pF	0.5±0.05	0.8±0.1	9.4 pF	0.5±0.05	0.8±0.1
6.4 pF	0.5±0.05	0.8±0.1	9.5 pF	0.5±0.05	0.8±0.1
6.5 pF	0.5±0.05	0.8±0.1	9.6 pF	0.5±0.05	0.8±0.1
6.6 pF	0.5±0.05	0.8±0.1	9.7 pF	0.5±0.05	0.8±0.1
6.7 pF	0.5±0.05	0.8±0.1	9.8 pF	0.5±0.05	0.8±0.1
6.8 pF	0.5±0.05	0.8±0.1	9.9 pF	0.5±0.05	0.8±0.1
6.9 pF	0.5±0.05	0.8±0.1	10 pF	0.5±0.05	0.8±0.1
7.0 pF	0.5±0.05	0.8±0.1	I2 pF	0.5±0.05	0.8±0.1
7.1 pF	0.5±0.05	0.8±0.1	15 pF	0.5±0.05	0.8±0.1
7.2 pF	0.5±0.05	0.8±0.1	18 pF	0.5±0.05	0.8±0.1
7.3 pF	0.5±0.05	0.8±0.1	22 pF	0.5±0.05	0.8±0.1
7.4 pF	0.5±0.05	0.8±0.1	27 pF	0.5±0.05	0.8±0.1
7.5 pF	0.5±0.05	0.8±0.1	33 pF	0.5±0.05	0.8±0.1
7.6 pF	0.5±0.05	0.8±0.1	39 pF	0.5±0.05	0.8±0.1
7.7 pF	0.5±0.05	0.8±0.1	47 pF	0.5±0.05	0.8±0.1
7.8 pF	0.5±0.05	0.8±0.1	56 pF	0.5±0.05	0.8±0.1
7.9 pF	0.5±0.05	0.8±0.1	68 pF	0.5±0.05	0.8±0.1
8.0 pF	0.5±0.05	0.8±0.1	82 pF	0.5±0.05	0.8±0.1
8.1 pF	0.5±0.05	0.8±0.1	100 pF	0.5±0.05	0.8±0.1

NOTE

- 1. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-12 series is on request





Surface-Mount Ceramic Multilayer Capacitors

High Frequency Automotive grade

NP0 16 V to 50 V

uci specification

THICKNESS CLASSES AND PACKING QUANTITY

Table 4

SIZE	THICKNESS	TAPE WIDTH -	Ø180	MM / 7 INCH	Ø330	MM / 13 INCH
CODE	CLASSIFICATION	QUANTITY PER REEL	Paper	Blister	Paper	Blister
0402	0.5 ±0.05 mm	8 mm	10,000		50,000	
0603	0.8 ±0.1 mm	8 mm	4,000		15,000	

ELECTRICAL CHARACTERISTICS

NP0 DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

Temperature: 15 °C to 35 °C
Relative humidity: 25% to 75%
Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

 Га	b	le	5
ıa	_		•

DESCRI	IPTION	VALUE
Capacita	ance range	0.1 pF to 100 pF
Capacita	ance tolerance	
NP0	C < 10 pF	±0.05 pF, ±0.1 pF, ±0.25 pF, ±0.5 pF
	C ≥ 10 pF	±1%, ±2%, ±5%
Dissipat	tion factor (D.F.)	
NP0	C < 30 pF	≤ I / (400 + 20C)
	C ≥ 30 pF	≤ 0.1 %
Insulatio	on resistance after I minute at U _r (DC)	IR≥ 10 GΩ
	m capacitance change as a function of temperature rature characteristic/coefficient):	
NP0		±30 ppm/°C
Operati	ing temperature range:	
NP0		−55 °C to +125 °C



SOLDERING RECOMMENDATION

Table 6					
SOLDERING	SIZE				
METHOD	0402	0603	0805	1206	≥ 1210
Reflow	≥ 0.1 µF	≥ 1.0 µF	≥ 2,2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave	< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

TESTS AND REQUIREMENTS

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202G-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 260 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

Table 7 Test procedures and requirements

TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage	
Capacitance	IEC 60384- 21/22	4.5.1	Class I: At 20 °C, 24 hours after annealing $f = I$ MHz for $C \le I$ nF, measuring at voltage I V _{rms} at 20 °C $f = I$ KHz for $C > I$ nF, measuring at voltage I V _{rms} at 20 °C	Within specified tolerance	
Dissipation Factor (D.F.)	IEC 60384- 21/22	4.5.2	Class I: At 20 °C, 24 hours after annealing $f = 1$ MHz for $C \le InF$, measuring at voltage $I \ V_{rms}$ at 20 °C $f = 1$ KHz for $C > InF$, measuring at voltage $I \ V_{rms}$ at 20 °C	In accordance with specification	
Insulation Resistance	IEC 60384- 21/22	4.5.3	At U _r (DC) for I minute	In accordance with specification	

TEST	TEST METH	IOD	PROCEDURE	REQUIREMENTS
Temperature coefficient		4.6	Capacitance shall be measured by the steps shown in the following table.	<general purpose="" series=""> Class I: Δ C/C: ± 30ppm</general>
			The capacitance change should be measured after 5 min at each specified temperature stage.	
			Step Temperature(°C)	
			a 25±2	
			b Lower temperature±3°C	
			c 25±2	
			d Upper Temperature±2°C	
			e 25±2	
			(I) Class I	
			Temperature Coefficient shall be calculated from the formula as below	
			Temp, Coefficient = $\frac{C2 - CI}{CI \times \Delta T} \times 10^6$ [ppm/°C]	
			C1: Capacitance at step c	
			C2: Capacitance at 125°C	
			ΔT : 100°C(=125°C-25°C)	
			(2) Class II	
			Capacitance Change shall be calculated from the	
			formula as below	
			$\Delta C = \frac{C2 - C1}{C1} \times 100\%$	
			C1: Capacitance at step c C2: Capacitance at step b or d	
High	AEC-Q200	3	Unpowered; 1000hours @ T=150°C	No visual damage
Temperature			Measurement at 24±2 hours after test conclusion.	Δ C/C :
Exposure				Class I:
				NP0: within ±0.5% or 0.5 pF whichever is greater
Temperature Cycling	AEC-Q200	4	Preconditioning: 150 +0/–10 °C for 1 hour, then keep for	No visual damage
			24 ±1 hours at room temperature	ΔC/C
			1000 cycles with following detail:	Class I:
			30 minutes at lower category temperature	NP0: Within $\pm 1\%$ or 0.5pF,
			30 minutes at upper category temperature	whichever is greater.
			Recovery time 24 ±2 hours	D.F. meet initial specified value IR meet initial specified value
Destructive Physical Analysis	AEC-Q200	5	Note: Only applies to SMD ceramics. Electrical test not required.	



TEST

Moisture

Resistance

Surface-Mount Ceramic Multilayer Capacitors

TEST METHOD

AEC-Q200

PROCEDURE

REQUIREMENTS T=24 hrs/per cycle; 10 continuous cycles unpowered. No visual damage

Measurement at 24 ±2 hours after test condition.

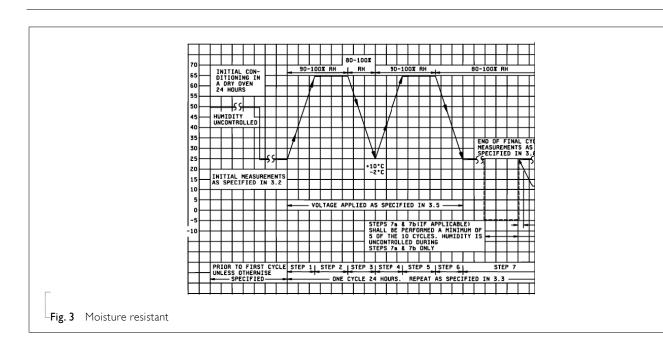
NPO: Within ±3% or 3 pF, whichever is greater

D.F.

 $\Delta C/C$

Within initial specified value

NP0: \geq 10,000 M Ω



Biased Humidity AEC-Q200

1. Preconditioning, class 2 only: 150 +0/-10 °C /I hour, then keep for 24 ±1 hour at room temp

2. Initial measure:

Parameter: IR

Measuring voltage: 1.5V ± 0.1 VDC Note: Series with $100 \text{ K}\Omega$

3. Test condition:

85 °C, 85% R.H. connected with 100 K Ω resistor, applied 1.5V/U_r for 1,000 hours.

4. Recovery:

Class I: 6 to 24 hours Class2: 24 ±2 hours

5. Final measure: IR

No visual damage after recovery

Initial requirement:

Class I:

- Connected to 100 K Ω : $C \le 10 \text{ nF: I.R} \ge 10,000 \text{ M}\Omega \text{ or}$ $C > 10 \text{ nF: } (I.R-100 \text{ K}\Omega) \times C \ge 100 \text{s.}$

Final measurement:

The insulation resistance shall be greater than 0.1 time initial value.





Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

NP0

16 V to 50 V

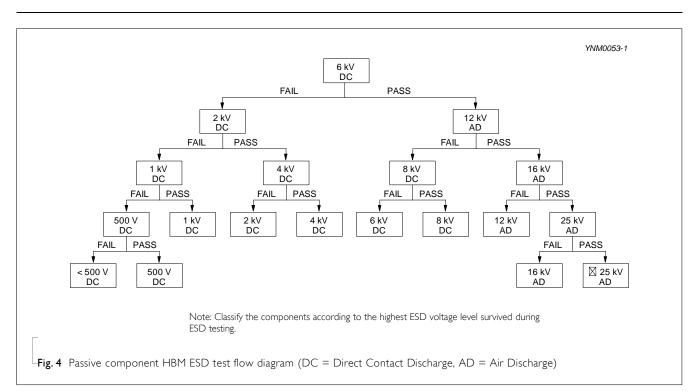
TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Operational Life	AEC-Q200	 I. Initial measure: Spec: refer to initial spec C, D, IR Endurance test: Specified stress voltage applied for 1,000 hours: Applied 2.0 × U_r for general products Recovery time: 24 ±2 hours Final measure: C, D, IR Note: If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirement shall be met. 		No visual damage $\Delta C/C$ NP0: Within $\pm 2\%$ or 1 pF, whichever is greater $D.F.$ NP0: $\leq 2 \times \text{specified value}.$ IR NP0: $\geq 4,000 \text{ M}\Omega$ or IR $\times C_r \geq 40\text{s}$ whichever is less	
External Visual	AEC-Q200	9	Any applicable method using × 10 magnification	In accordance with specification	
Physical Dimension	AEC-Q200	10	Verify physical dimensions to the applicable device specification.	In accordance with specification	
Mechanical Shock	AEC-Q200	13	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500 g's Duration: 0.5 ms Velocity change: 15.4 ft/s Waveform: Half-sin	ΔC/C NP0: Within ±0.5% or 0.5 pF, whichever is greater D.F. Within initial specified value IR	
				Within initial specified value	
Vibration	AEC-Q200	14	5 g's for 20 minutes, 12 cycles each of 3 orientations. Note: Use 8" × 5" PCB. 0.31" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz.	ΔC/C NP0: Within ±0.5% or 0.5 pF, whichever is greater D.F: meet initial specified value IR meet initial specified value	
Resistance to Soldering Heat	AEC-Q200	15	Precondition: I50 ±0/−10 °C for I hour, then keep for 24 ±1 hours at room temperature Preheating: for size ≤ I206: I20 °C to I50 °C for I minute Preheating: for size > I206: I00 °C to I20 °C for I minute and I70 °C to 200 °C for I minute Solder bath temperature: 260 ±5 °C Dipping time: I0 ±0.5 seconds Recovery time: 24 ±2 hours	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned \[\Delta C/C \] Class I: NPO: Within ±1% or 0.5 pF, whichever is greater. D.F. within initial specified value IR within initial specified value	

YAGEO

NP0

16 V to 50 V

TEST	TEST METHOD		PROCEDURE	REQUIREMENTS		
Thermal Shock	AEC-Q200	16	 Preconditioning, class 2 only: 150 +0/-10 °C /I hour, then keep for 24 ±1 hour at _ 	No visual damage		
			room temp 2. Initial measure:	$\Delta C/C$ NP0: Within ±1% or 1 pF, whichever		
			Spec: refer to initial spec C, D, IR 3. Rapid change of temperature test:	is greater		
	NP0: -55 °C to +125 °C; 300 cycles	•	D.F: meet initial specified value			
			15 minutes at lower category temperature; 15 minutes at upper category temperature.	IR meet initial specified value		
			4. Recovery time:			
			Class I: 6 to 24 hours			
			Class2: 24 ±2 hours			
			5. Final measure: C, D, IR			
ESD	AEC-Q200	17	Per AEC-Q200-002	A component passes a voltage level if all components stressed at that voltage level pass.		



YAGEO

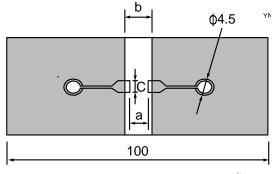
Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

NP0

16 V to 50 V

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS		
Solderability	AEC-Q200	18	Preheated to a temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination.		
			Test conditions for lead containing solder alloy			
			Temperature: 235 ±5 °C			
			Dipping time: 2 ±0.2 seconds			
			Depth of immersion: 10 mm			
			Alloy Composition: 60/40 Sn/Pb			
			Number of immersions: I			
			Test conditions for lead-free containing solder alloy			
			Temperature: 245 ±5 °C			
			Dipping time: 3 ±0.3 seconds			
			Depth of immersion: 10 mm			
			Alloy Composition: SAC305			
			Number of immersions: I			
Electrical	AEC-Q200	EC-Q200 19	requirements, summary to show Min, Max, Mean and	ΔC/C		
Characterization				Class I:		
			Standard deviation at room as well as Min and Max operating temperatures.	NP0: ±30 ppm/°C		
			Class I:			
			NP0: -55 °C to +125 °C			
			Normal temperature: 20 °C			
Board Flex	AEC-Q200	21	Part mounted on a 100 mm \times 40 mm FR4 PCB board, which is 1.6 \pm 0.2 mm thick and has a layer-thickness 35	No visible damage		
			μm ± 10 μm.	ΔC/C		
			Part should be mounted using the following soldering			
			reflow profile.	Class I:		
			Conditions:	NPO: Within ±1% or 0.5 pF,		
			Class I:	whichever is greater		
			Bending 3 mm at a rate of 1 mm/s, radius jig 340 mm			
			Benefit of third at a race of 1 minus, radius jig 5 10 min			

Test Substrate:



unit:	mm

	Dimension(mm)		
Туре	а	b	С
0201	0.3	0.9	0.3
0402	0.4	1.5	0.5
0603	1.0	3.0	1.2
0805	1.2	4.0	1.65
1206	2.2	5.0	1.65
1210	2.2	5.0	2.0
1808	3.5	7.0	3.7



Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

NP0

16 V to 50 V

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Terminal Strength	AEC-Q200 22		With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested. This force shall be applied for 60+1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. * Apply 2N force for 0402 size.	Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body, terminals and body/terminal junction. Before, during and after the test, the device shall comply with all electrical requirements stated in this specification.
Beam Load Test	AEC-Q200	23	Place the part in the beam load fixture. Apply a force until the part breaks or the minimum acceptable force level required in the user specification(s) is attained.	\leq 0805 Thickness $>$ 0.5mm: 20N Thickness \leq 0.5mm: 8N \geq 1206 Thickness \geq 1.25 mm: 54N Thickness $<$ 1.25 mm: 15N
Voltage Proof			 Specified stress voltage applied for 1~5 seconds Ur ≤ 100 V: series applied 2.5 Ur 100 V < Ur ≤ 200 V series applied (1.5 Ur + 100) 200 V < Ur ≤ 500 V series applied (1.3 Ur + 100) Ur > 500 V: 1.3 Ur Ur ≥ 1000 V: 1.2 Ur Charge/Discharge current is less than 50 mA 	No breakdown or flashover
ESR			Measuring frequency: 1 ± 0.2GHz at room temperature.	$0.1 \text{pF} \le C \le 1 \text{pF} : 350 \text{m}\Omega / C \text{max}$ $1 \text{pF} < C \le 5 \text{pF} : 300 \text{m}\Omega \text{max}$ $5 \text{pF} < C \le 10 \text{pF} : 250 \text{m}\Omega \text{max}$ $C : \text{Nominal cap (pF)}$
			Measuring frequency: $500 \pm 50 \text{MHz}$ at room temperature.	10pF < C ≤ 100pF :400mΩ max



Product specification $\frac{14}{15}$ Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade 16 V to 50 V NP0

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version I	Feb. 08, 2021	-	- Add 0402 / 0.1 pf~ 100pF
Version 0	Dec. 14, 2018	-	- New



Surface-Mount Ceramic Multilayer Capacitors

LEGAL DISCLAIMER

YAGEO, its distributors and agents (collectively, "YAGEO"), hereby disclaims any and all liabilities for any errors, inaccuracies or incompleteness contained in any product related information, including but not limited to product specifications, datasheets, pictures and/or graphics. YAGEO may make changes, modifications and/or improvements to product related information at any time and without notice.

YAGEO makes no representation, warranty, and/or guarantee about the fitness of its products for any particular purpose or the continuing production of any of its products. To the maximum extent permitted by law, YAGEO disclaims (i) any and all liability arising out of the application or use of any YAGEO product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for a particular purpose, non -infringement and merchantability.

YAGEO products are designed for general purpose applications under normal operation and usage conditions. Please contact YAGEO for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property: Aerospace equipment (artificial satellite, rocket, etc.), Atomic energy-related equipment, Aviation equipment, Disaster prevention equipment, crime prevention equipment, Electric heating apparatus, burning equipment, Highly public information network equipment, data-processing equipment, Medical devices, Military equipment, Power generation control equipment, Safety equipment, Traffic signal equipment, Transportation equipment and Undersea equipment, or for any other application or use in which the failure of YAGEO products could result in personal injury or death, or serious property damage. Particularly YAGEO Corporation and its affiliates do not recommend the use of commercial or automotive grade products for high reliability applications or manned space flight.

Information provided here is intended to indicate product specifications only. YAGEO reserves all the rights for revising this content without further notification, as long as products are unchanged. Any product change will be announced by PCN.



单击下面可查看定价,库存,交付和生命周期等信息

>>Yageo(国巨)